



Platform-ZERO

TOWARDS ZERO-DEFECT MANUFACTURING IN THE PV INDUSTRY: REAL-TIME PROCESS MONITORING DRIVEN BY MATERIALS CHARACTERIZATION AND AI ALGORITHMS

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Meet the Consortium

12 European Partners

















HZB Helmholtz Zentrum Berlin







1. <u>Technology developing partners:</u>

- **a)** Four research centers and one university with knowledge in the development of spectroscopic methodologies (IREC, HZB), imaging (AIT), device optoelectronic assessment (UPO), AI analysis (AIT, IREC, RISC) and data management (RISC).
- **b) Metrology SME** with strong know-how in the implementation of industrial process monitoring applications (LENZ).

2. <u>Technology testing partners (Demo sites):</u>

- **a) Two research centers** with know-how in advanced PV technologies and with industrial pilot lines to validate concepts based on CIGS solar modules (ZSW) and nanoparticles-based surface processes and coatings (Lurederra).
- **b) Two third-generation PV manufacturing SMEs** (SUNPLUGGED and SAULE), both providing their production lines for demonstrating the Platform-ZERO technology.
- **3.** <u>**DEC:</u> two partners** (R2M Solution France and R2M Solution SRL Italy) for dissemination, exploitation and communication actions.</u>



THE CONSORTIUM



Context

- Solar photovoltaic (PV) provides an important contribution to the European energy mix, equal to 3.1% of EU-28 gross electricity generation in 2020 (source: Eurostat).
- Furthermore, solar energy has the potential to meet 20% of the EU electricity demand in 2040 (source: BloombergNEF).
- The latest generation of PV technologies combine high performance with a strong flexibility for integration in buildings, vehicles, agrivoltaics and internet-of-things devices.



Cross-section of a PV device However, the high **complexity of Complex device** the latest generation of PV тсо 1µm **Electrons selector** Window layer (150-500 nm) technologies makes them prone Buffer (20-80 nm) → Stack of ≥6 layers. Light absorber to the appearance of critical → Hundreds of fabrication (hole-e pair generation) parameters Absorber (1-2 um) **defects**, leading to significant Hole selector layer → Strong interaction between layers and parameters Back contact production waste Back contact (0.5-1 um) Substrate Substrate (50 um to mm) **Complex fabrication** PV device Sputtering: Scribing: Annealing: Glass Substrate Sputtering: Sputtering: Annealing: CBD: Front Devices System Metallic Back Light Absorber Absorber Carriers stabilization Transparent discretization synthesis separation contact precursor

stack

contact stack

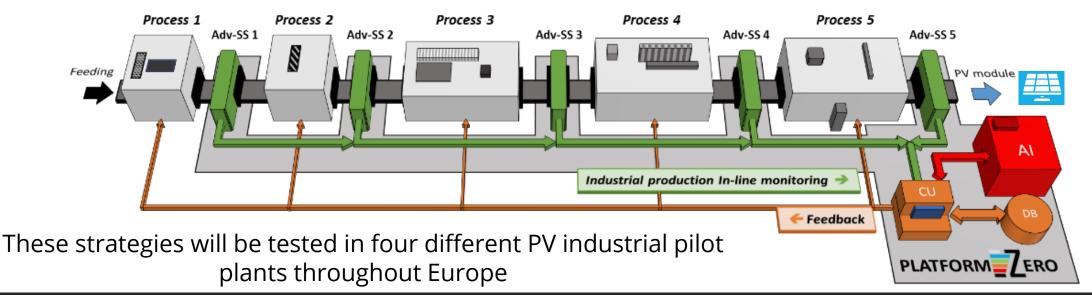
ABOUT THE PROJECT

Platform-ZERO addresses this challenge aiming at reaching zero defect manufacturing for the photovoltaic industry



In-line process monitoring, control and artificial intelligence strategies are key technologies:

- to **allow early detection**, correction and/or prevention of pre-critical production faults
- to substantially reduce production costs and improve quality for industry in the photovoltaic sector



ABOUT THE PROJECT

Demo sites

Platform-ZERO innovations will be tested in 4 PV industrial pilot plants throughout Europe: Spain, Germany, Poland and Austria



| Pilot Line | centro tecnológico | | suplugged | |
|----------------------|--|---|---------------------------------|--------------------------------------|
| Pilot line objective | Technology Demonstration / optimization | Technology Demonstration / optimization | Production | Production |
| Products | Oxide based smart coatings | High efficiency CIGSe- based PV | Customizable CIGSe- based PV | Customizable Perovskite- based PV |
| Product Image | | | | |
| Production process | Discontinued (batch) | Sheet-to-Sheet (StS) | Roll-To-Roll (RtR) | Front end of Line (FEOL) |
| | Research Pilot-line (Laboratory to Industry) | | Industrial Pilot-line | |

Different type of industries in terms of: PV products, production methods, materials fabrication, and samples management



Demonstration of suitability of Platform-Zero process monitoring platform

OVERALL OBJECTIVES

To develop a modular in-line process monitoring and control solution for the third-generation PV industry



Sensor Stations To develop advanced sensor stations compatible with customizable sensor arrays for morphological, physicochemical and optoelectronic in-line inspection of PV materials and devices



Data Management

To develop a big data infrastructure, control unit and GUI software for managing the large amount of data generated by the platform



Al System To develop an innovative Al-based prediction and decision-making system along with

methodologies

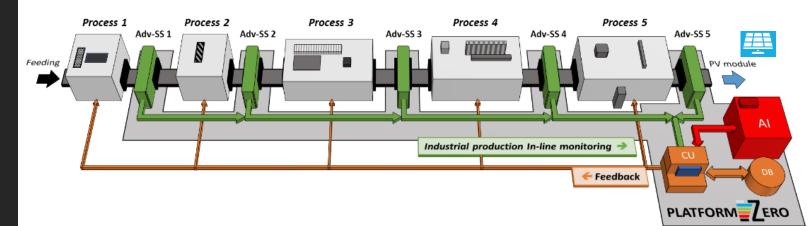
compatible with

heterogeneous data,

real-time monitoring,

and process control

Monitoring Platform To implement and install a process monitoring platform in 4 PV manufacturing line



Photovoltaic Devices

To optimize PV manufacturing by validating the process monitoring and control platform developed to minimize production defects

TECHNICHAL MAPPING & METHODOLGY

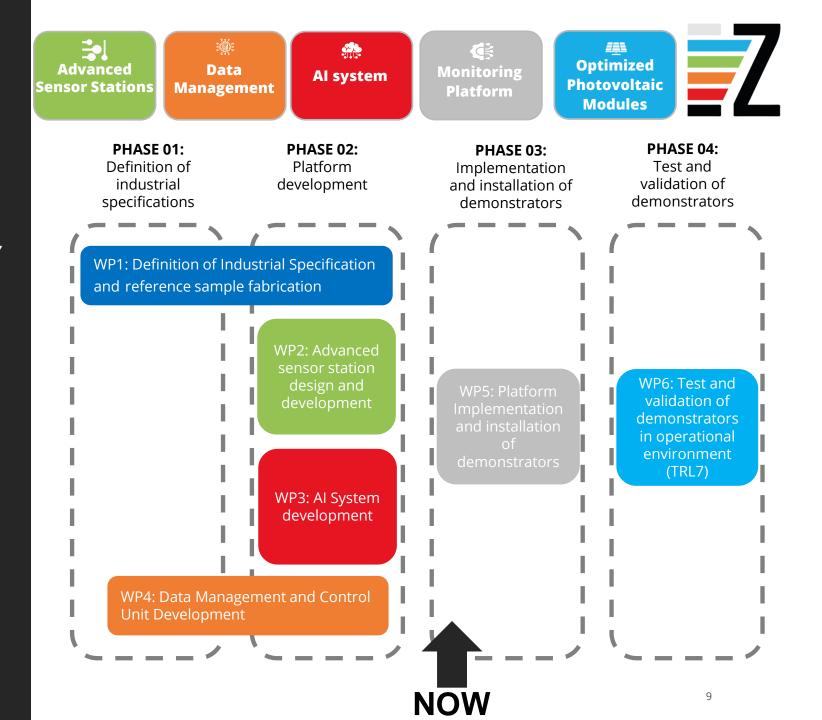
4M approach

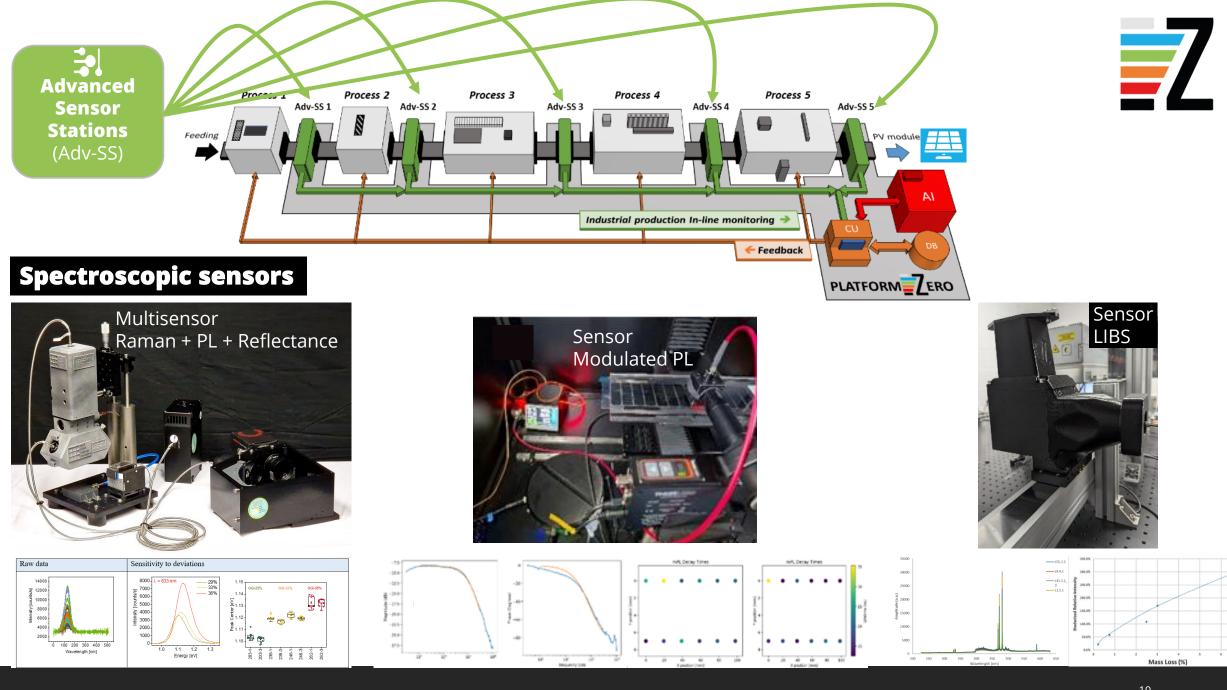
•Mapping (year 1)

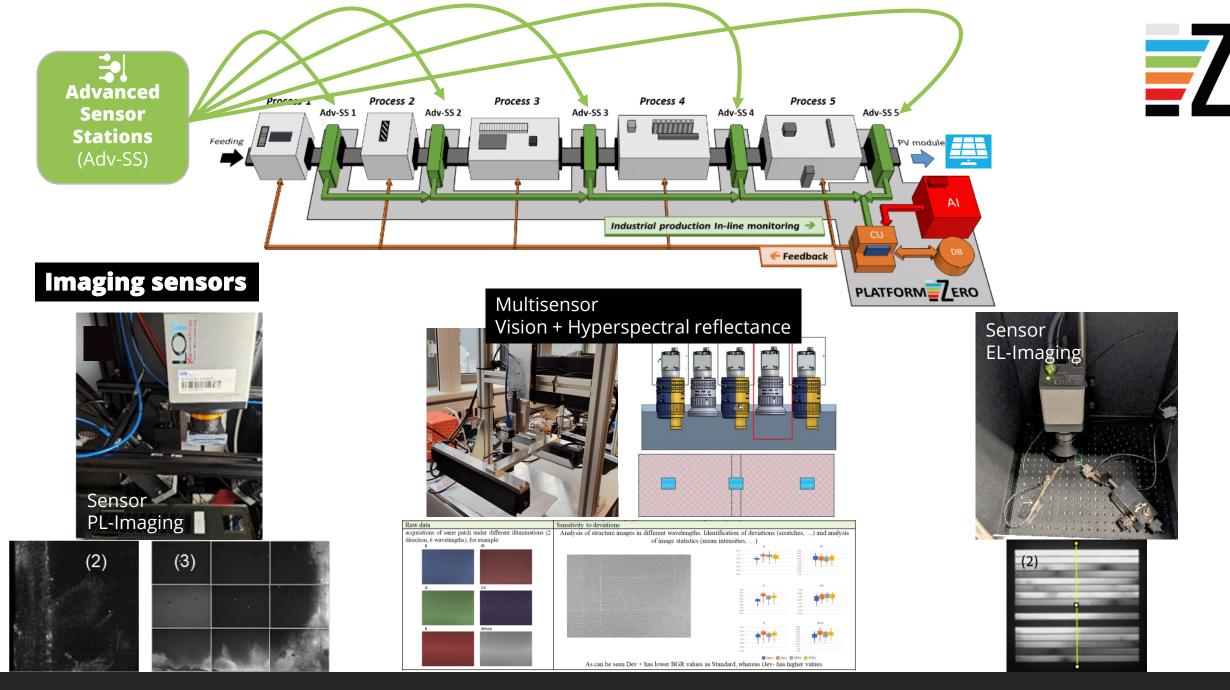
Manufacturing (year 2)

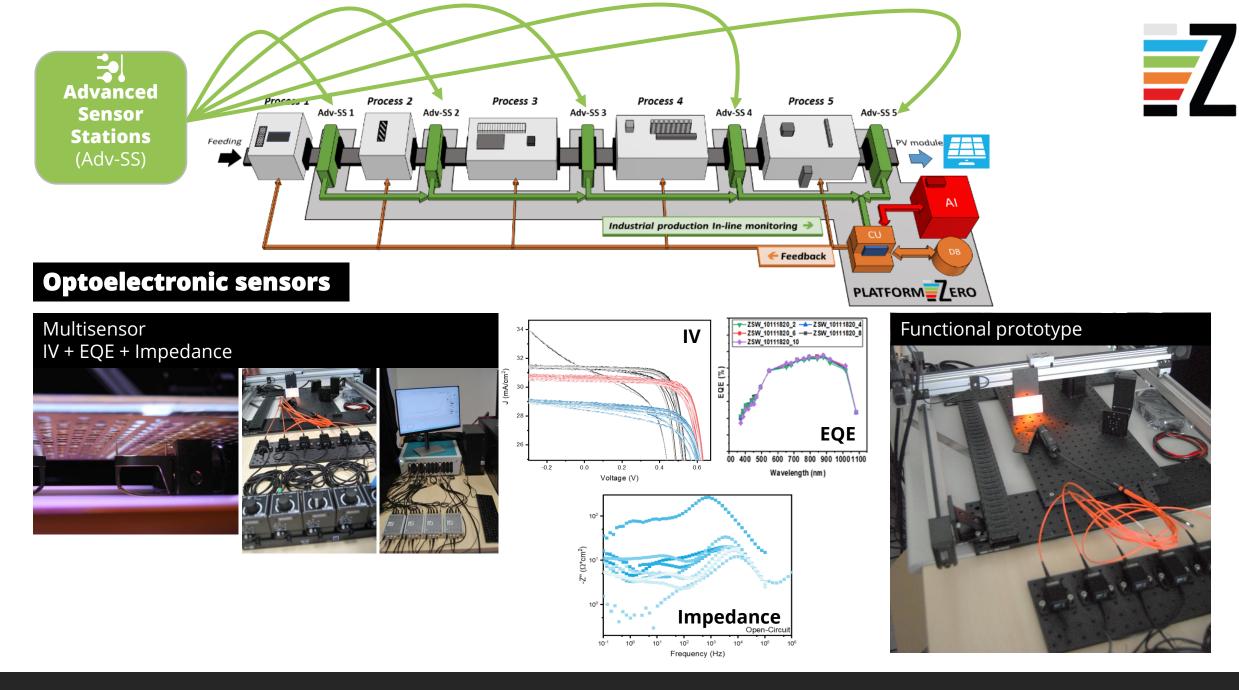
•Making (year 3)

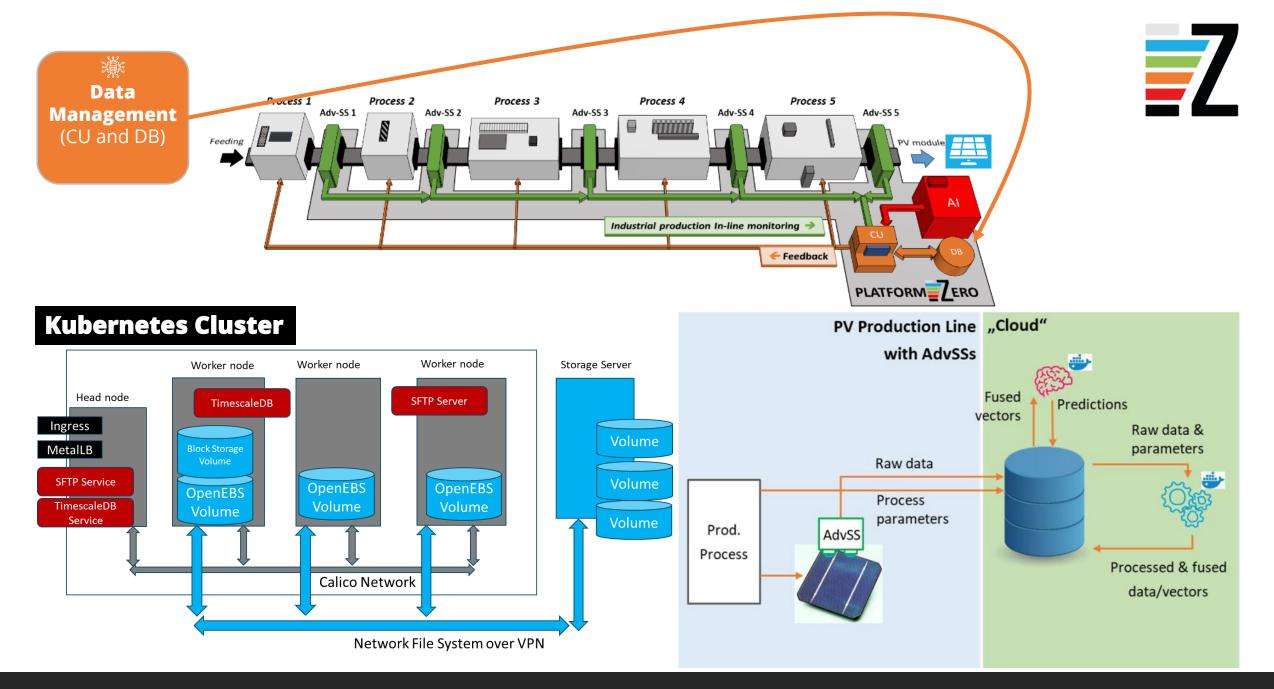
Monitoring (year 4)

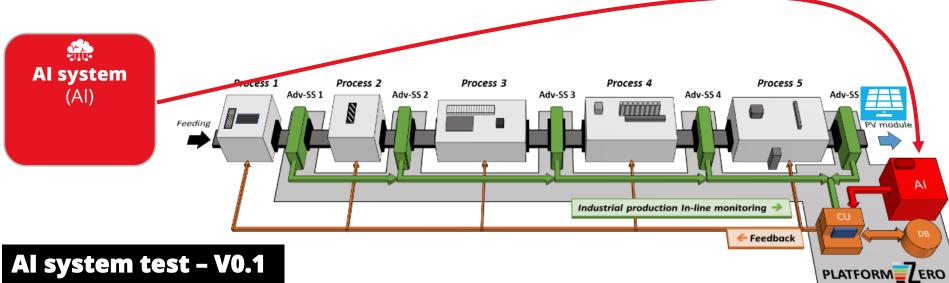










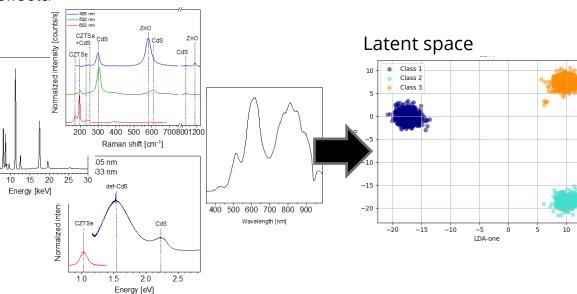


Research samples with >1500 data points split in 3 classes: 1 good; 2 – acceptable; 3 – bad.



Coherent dataset with results from combined characterization by means of XRF, Raman, PL, Reflectance

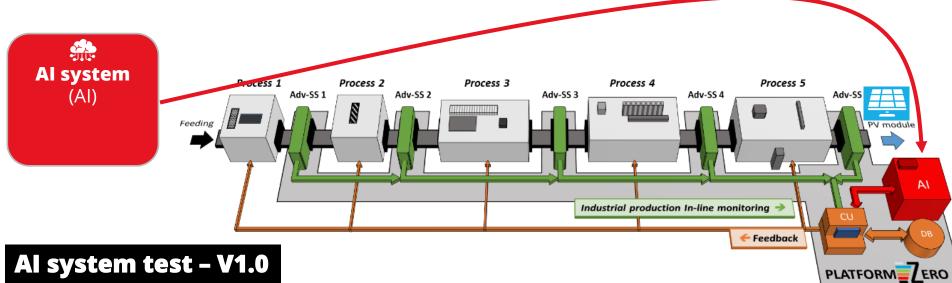
5 0



Classification scores

15

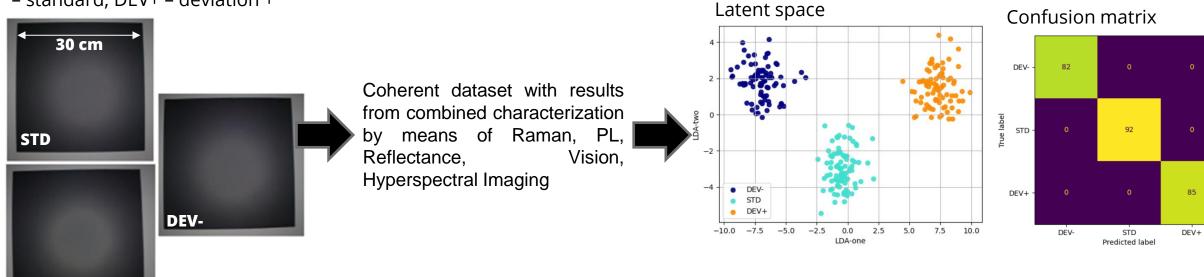
| | Accuracy | F1 score |
|-------------|----------|----------|
| | (%) | (%) |
| PL405 | 87.5 | 87.3 |
| PL633 | 83.8 | 83.5 |
| Raman405 | 69.8 | 69.2 |
| Raman532 | 69.4 | 68.7 |
| Raman633 | 56.6 | 55.9 |
| HypImg. | 29.2 | 37.4 |
| Reflectance | 97.0 | 97.0 |
| XRF | 51.5 | 54.8 |
| ALL | 100.0 | 100.0 |

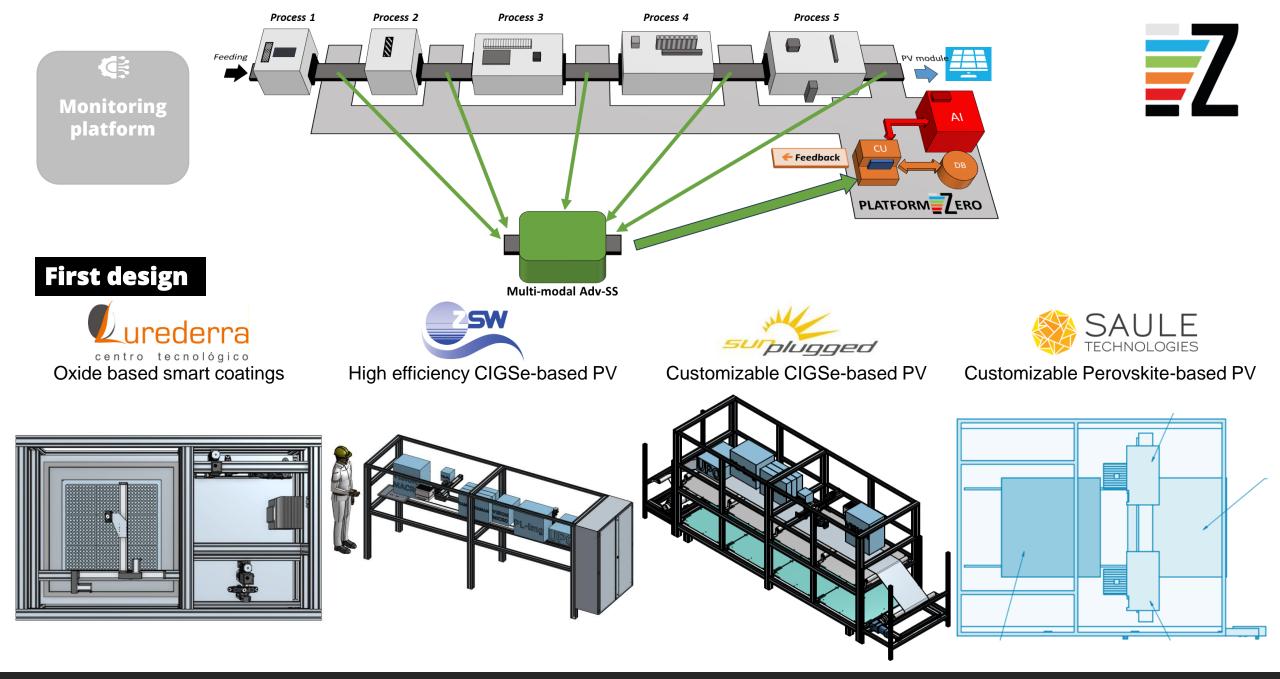




Samples from a pilot line split in 3 classes: DEV- - deviation -; STD - standard; DEV+ - deviation +

DEV+





PROJECT OUTPUT, KERS AND IMPACTS



Develop of dedicated high sensitivity inspection sensors

Develop strategies for real StS and RtR in-line monitoring

Implementation of AI-based algorithms library

Implementation of data management and control algorithms library

Implementation of costumizables GUI software for monitoring, data visualization and decision-making advising

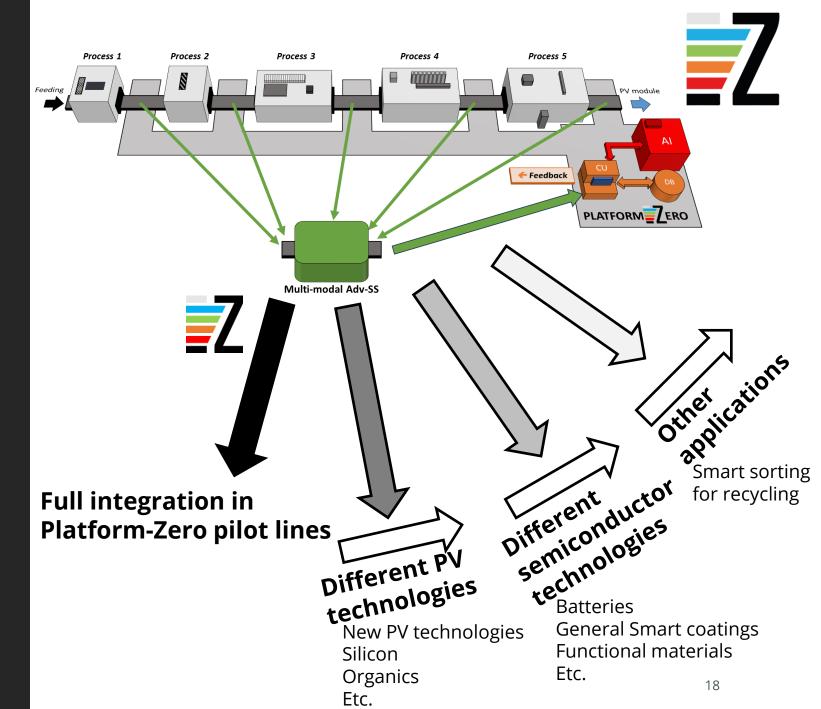
Implementation of fully operational platform demonstrators compatible with a real-time industrial process monitoring

Detection of process deviations

10% increase in productivity of the EU's PV industry

10% decreased requirement of high-value raw materials required for the production of PV devices

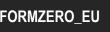
FUTURE TRANSFERENCE





THANK YOU, GET IN TOUCH





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